

Notice of References Cited

Application/Control No.

10/567,548

Applicant(s)/Patent Under
Reexamination
YOSHIMINE, TAKASHI

Examiner

MARTIN LERNER

Art Unit

2626

Page 1 of 1

U.S. PATENT DOCUMENTS

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Name	Classification
*	A	US-2002/0140718	10-2002	Yan et al.	345/706
*	B	US-2002/0178344	11-2002	Bourguet et al.	712/1
*	C	US-7,110,951	09-2006	Lemelson et al.	704/270
*	D	US-6,483,532	11-2002	Girod, Bernd	348/14.12
*	E	US-6,417,797	07-2002	Cousins et al.	342/179
*	F	US-6,256,400	07-2001	Takata et al.	382/103
*	G	US-6,317,716	11-2001	Braida et al.	704/275
*	H	US-5,047,952	09-1991	Kramer et al.	704/271
*	I	US-2003/0223455	12-2003	Rashdan, Osama	370/466
*	J	US-2006/0234193	10-2006	Sahashi, Nozomu	434/112
*	K	US-7,395,200	07-2008	Roston, John	704/3
*	L	US-6,477,239	11-2002	Ohki et al.	379/52
*	M	US-6,460,056	10-2002	Horii, Hiroyuki	715/203

FOREIGN PATENT DOCUMENTS

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Country	Name	Classification
	N					
	O					
	P					
	Q					
	R					
	S					
	T					

NON-PATENT DOCUMENTS

*		Include as applicable: Author, Title Date, Publisher, Edition or Volume, Pertinent Pages)
	U	
	V	
	W	
	X	

*A copy of this reference is not being furnished with this Office action. (See MPEP § 707.05(a).)
Dates in MM-YYYY format are publication dates. Classifications may be US or foreign.